

**Search Notes**

Application/Control No.

10/647,520

Examiner

Edgardo San Martin

Applicant(s)/Patent under  
Reexamination

CHOI ET AL.

Art Unit

2837

**SEARCHED**

Class	Subclass	Date	Examiner
181	270,279 280,281 264	8/20/2005	ESM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text search East for 181/224,225,226; 123/184.21,184.53,590,593,592; 454/206 see printout	8/20/2005	ESM